

The Communications Edge TM

Product Information

Product Features

- 400 2300 MHz
- +33 dBm P1dB
- +51 dBm Output IP3
- 18 dB Gain @ 900 MHz
- +5V Single Positive Supply
- MTTF > 100 Years
- Lead-free/green/RoHS-compliant SOIC-8 SMT Pkg.

Applications

- Final stage amplifiers for Repeaters
- Mobile Infrastructure

Specifications (1)

| Parameter | Units | Min | Тур | Max |
|--|-------|-----|-------|------|
| Operational Bandwidth | MHz | 400 | | 2300 |
| Test Frequency | MHz | | 2140 | |
| Gain | dB | 9 | 10 | |
| Input R.L. | dB | | 20 | |
| Output R.L. | dB | | 6.8 | |
| Output P1dB | dBm | +32 | +33.2 | |
| Output IP3 ⁽²⁾ | dBm | +47 | +48 | |
| IS-95A Channel Power @ -45 dBc ACPR, 1960 MHz | dBm | | +27.5 | |
| wCDMA Channel Power @ -45 dBc ACLR, 2140 MHz | dBm | | +25.3 | |
| Noise Figure | dB | | 7.7 | |
| Operating Current Range, Icc (3) | mA | 700 | 800 | 900 |
| Device Voltage, Vcc | V | | +5 | |

Test conditions unless otherwise noted: 25°C, +5V Vsupply, 2140 MHz, in tuned application circuit.
3OIP measured with two tones at an output power of +17 dBm/tone separated by 1 MHz. The suppression on the largest IM3 product is used to calculate the 3OIP using a 2:1 rule.

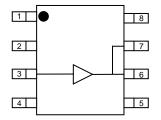
Suppression on the fuger with product outrent or operating current under small-signal conditions into pins 6, 7, and 8. It is expected that the current can increase by an additional 200 mA at P1dB. Pin 1 is used as a reference voltage for the internal biasing circuitry. It is expected that Pin 1 will pull 22mA of current when used with a series bias resistor of R1=15Ω. (ie. total device current typically will be 822 mA.)

Product Description

The AH312 is a high dynamic range driver amplifier in a low-cost surface mount package. The InGaP/GaAs HBT is able to achieve high performance for various narrowband-tuned application circuits with up to +49 dBm OIP3 and +33 dBm of compressed 1dB power. It is housed in a lead-free/green/RoHS-compliant SOIC-8 package. All devices are 100% RF and DC tested.

The AH312 is targeted for use as a driver amplifier in wireless infrastructure where high linearity and medium power is required. An internal active bias allows the AH312 to maintain high linearity over temperature and operate directly off a single +5V supply. This combination makes the device an excellent candidate for transceiver line cards in current and next generation multi-carrier 3G base stations.

Functional Diagram



| Function | Pin No. |
|------------|-----------------|
| Vref | 1 |
| Input | 3 |
| Output | 6, 7 |
| Vbias | 8 |
| GND | Backside Paddle |
| N/C or GND | 2, 4, 5 |

Typical Performance⁽⁴⁾

| Parameter | Units | | Typical | |
|--|-------|-----|-----------|-------|
| Frequency | MHz | 900 | 1960 | 2140 |
| S21 – Gain | dB | 18 | 11 | 10 |
| S11 – Input R.L. | dB | -18 | -19 | -20 |
| S22 – Output R.L. | dB | -11 | -6.8 | -6.8 |
| Output P1dB | dBm | +33 | +33.4 | +33.2 |
| Output IP3 | dBm | +49 | +51 | +48 |
| IS-95A Channel Power @ -45 dBc ACPR | dBm | +27 | +27.5 | |
| @ -45 dBc ACLR | dBm | | | +25.3 |
| Noise Figure | dB | 8.0 | 7.3 | 7.7 |
| Device Bias ⁽³⁾ | | +5 | V @ 800 1 | mA |

4. Typical parameters reflect performance in a tuned application circuit at +25° C.

Absolute Maximum Rating

| Parameter | Rating |
|-----------------------------|----------------|
| Operating Case Temperature | -40 to +85 °C |
| Storage Temperature | -65 to +150 °C |
| RF Input Power (continuous) | +28 dBm |
| Device Voltage | +8 V |
| Device Current | 1400 mA |
| Device Power | 8 W |
| Junction Temperature | +250 °C |

Ordering Information

| Part No. | Description |
|-----------------|---|
| AH312-S8G | 2 Watt, High Linearity InGaP HBT Amplifier (lead-free/green/RoHS-compliant SOIC-8 Pkg) |
| AH312-S8PCB900 | 900 MHz Evaluation Board |
| AH312-S8PCB1960 | 1960 MHz Evaluation Board |
| AH312-S8PCB2140 | 2140 MHz Evaluation Board |

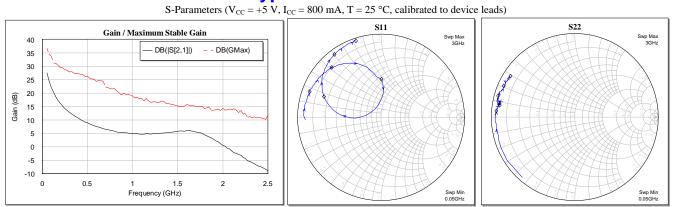
Operation of this device above any of these parameters may cause permanent damage.



The Communications Edge TM

Product Information

Typical Device Data



Notes:

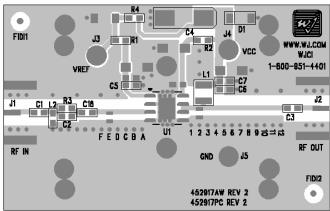
The gain for the unmatched device in 50 ohm system is shown as the trace in black color. For a tuned circuit for a particular frequency, it is expected that actual gain will be higher, up to the maximum stable gain. The maximum stable gain is shown in the dashed red line. The impedance plots are shown from 50 - 3000 MHz, with markers placed at 0.5 - 3.0 GHz in 0.5 GHz increments.

| S-Parameters ($V_{CC} = +5 V$, $I_{CC} = 800 mA$, $T = 25 °C$, unmatched 50 ohm system, calibrated t | to device leads) |
|--|------------------|
|--|------------------|

| D I municicità (V | $\mathcal{U} = 15$, \mathcal{U} | = 000 mm 1, 1 = | 25 C, uninated | ieu 50 onni syst | em, canorateu | to device leads) | | |
|-------------------|------------------------------------|-----------------|----------------|------------------|---------------|------------------|----------|-----------|
| Freq (MHz) | S11 (dB) | S11 (ang) | S21 (dB) | S21 (ang) | S12 (dB) | S12 (ang) | S22 (dB) | S22 (ang) |
| 50 | -0.86 | -178.06 | 27.55 | 113.72 | -45.75 | 30.91 | -0.38 | -130.98 |
| 100 | -0.64 | 178.18 | 22.16 | 98.81 | -45.46 | 12.80 | -0.38 | -157.30 |
| 200 | -0.68 | 172.85 | 16.13 | 89.06 | -42.65 | 6.09 | -0.48 | -172.51 |
| 400 | -0.76 | 164.33 | 10.61 | 77.31 | -43.96 | 4.69 | -0.48 | 177.51 |
| 600 | -0.93 | 155.56 | 7.46 | 67.94 | -41.17 | 6.70 | -0.61 | 173.63 |
| 800 | -1.15 | 146.04 | 5.78 | 57.62 | -41.65 | -5.78 | -0.66 | 170.49 |
| 1000 | -1.50 | 134.58 | 4.87 | 46.90 | -40.36 | -7.84 | -0.71 | 169.31 |
| 1200 | -2.39 | 121.66 | 4.74 | 32.96 | -40.22 | -16.51 | -0.80 | 168.22 |
| 1400 | -4.47 | 104.01 | 5.33 | 14.01 | -38.97 | -48.82 | -0.76 | 167.91 |
| 1600 | -11.96 | 86.06 | 5.96 | -17.55 | -38.96 | -86.32 | -0.60 | 170.63 |
| 1800 | -8.66 | -179.11 | 4.41 | -56.78 | -39.35 | -144.53 | -0.52 | 167.41 |
| 2000 | -2.76 | 159.91 | 0.53 | -89.86 | -43.55 | 145.94 | -0.41 | 164.50 |
| 2200 | -1.21 | 142.90 | -3.21 | -107.99 | -41.56 | 104.25 | -0.54 | 160.11 |
| 2400 | -0.68 | 130.93 | -7.27 | -123.14 | -42.46 | 73.64 | -0.68 | 157.84 |
| 2600 | -0.43 | 121.91 | -10.41 | -134.93 | -39.71 | 64.28 | -0.73 | 154.66 |
| 2800 | -0.32 | 114.61 | -13.28 | -143.22 | -40.99 | 58.20 | -0.73 | 151.14 |
| 3000 | -0.29 | 108.16 | -15.94 | -149.93 | -39.65 | 48.40 | -0.79 | 147.52 |

Device S-parameters are available for download off of the website at: http://www.wj.com

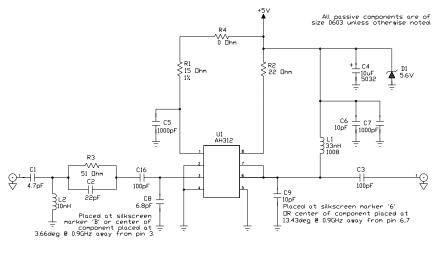
Application Circuit PC Board Layout



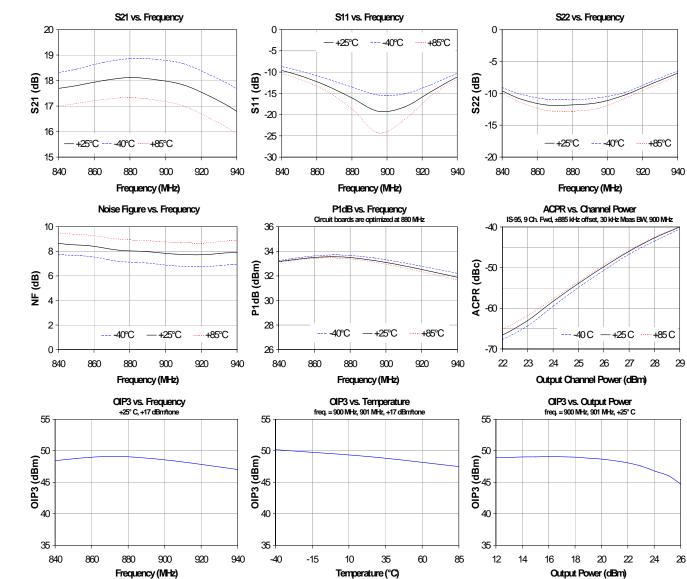
Circuit Board Material: .014" Getek, single layer, 1 oz copper, Microstrip line details: width = .026", spacing = .026" The silk screen markers 'A', 'B', 'C', etc. and '1', '2', '3', etc. are used as placemarkers for the input and output tuning shunt capacitors – C8 and C9. The markers and vias are spaced in .050" increments.

900 MHz Application Circuit (AH312-S8PCB900)

| Typical RF Performance at 25 °C | | |
|--|---------|--|
| Frequency | 900 MHz | |
| S21 – Gain | 18 dB | |
| S11 – Input Return Loss | -18 dB | |
| S22 – Output Return Loss | -11 dB | |
| Output P1dB | +33 dBm | |
| Output IP3 (+17 dBm / tone, 1 MHz spacing) | +49 dBm | |
| Channel Power (@-45 dBc ACPR, IS-95 9 channels fwd) | +27 dBm | |
| Noise Figure | 8.0 dB | |
| Device / Supply Voltage | +5 V | |
| Quiescent Current (1) | 800 mA | |

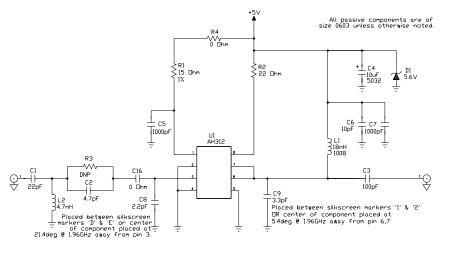


 This corresponds to the quiescent current or operating current under small-signal conditions into pins 6, 7, and 8.



1960 MHz Application Circuit (AH312-S8PCB1960)

| Typical RF Performance at 25 °C | | |
|--|-----------|--|
| Frequency | 1960 MHz | |
| S21 – Gain | 11 dB | |
| S11 – Input Return Loss | -20 dB | |
| S22 – Output Return Loss | -6.8 dB | |
| Output P1dB | +33.4 dBm | |
| Output IP3 (+17 dBm / tone, 1 MHz spacing) | +51 dBm | |
| Channel Power (@-45 dBc ACPR, IS-95 9 channels fwd) | +27.5 dBm | |
| Noise Figure | 7.3 dB | |
| Device / Supply Voltage | +5 V | |
| Quiescent Current ⁽¹⁾ | 800 mA | |



1. This corresponds to the quiescent current or operating current under small-signal conditions into pins 6, 7, and 8.

13

12

10

9

8

55

50

(mab) Equo

40

35

1930

1940

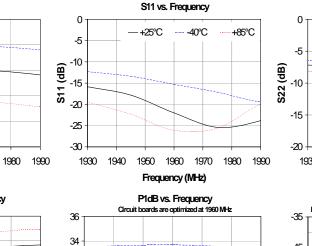
1950

1960 1970

Frequency (MHz)

1930

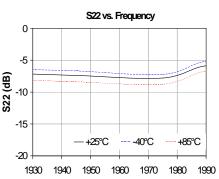
S21 (dB) 11 S21 vs. Frequency



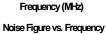
+85°C

1980

1970



Frequency (MHz)



1960

+85°C

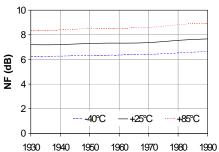
1970

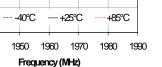
-40°C

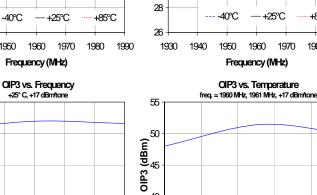
1950

+25℃

1940







40

35

-40

-15

10

Temperature (°C)

35

P1dB (dBm)

32

30

ACPR vs. Channel Power IS-95, 9 Ch. Fwd, ±885 kHz offset, 30 kHz Meas BW, 1960 MHz -45 ACPR (dBc) -55 -65 40 C +25 C +85 C -75 1990 22 23 24 25 26 27 28 Output Channel Power (dBm)



Specifications and information are subject to change without notice.

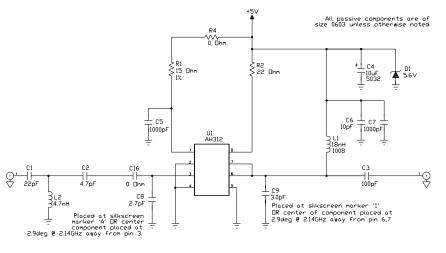
1990

1980

29

2140 MHz Application Circuit (AH312-S8PCB2140)

| Typical RF Performance at 25 °C | | |
|--|----------------|--|
| Frequency | 2140 MHz | |
| S21 – Gain | 10 dB | |
| S11 – Input Return Loss | -20 dB | |
| S22 – Output Return Loss | -6.8 dB | |
| Output P1dB | +33.2 dBm | |
| Output IP3 (+17 dBm / tone, 1 MHz spacing) | +48 dBm | |
| wCDMA Channel Power (@-45 dBc ACLR, 3GPP, TM 1+64 DPCH) | +25.3 dBm | |
| Noise Figure | 7.7 dB | |
| Device / Supply Voltage | +5 V | |
| Quiescent Current ⁽¹⁾ | 800 mA | |
| Device / Supply Voltage | +5 V 800 mA | |



0

1. This corresponds to the quiescent current or operating current under small-signal conditions into pins 6, 7, and 8.

-40℃

-40°C

2110 2120 2130 2140

+25℃

12

11

10

9

8

7

10

8

4

2

0

55

50

(mab) Equo

40

35

2110

2110 2120

NF (dB) 6

S21 (dB)

S21 vs. Frequency

+85°C

Frequency (MHz)

Noise Figure vs. Frequency

2150

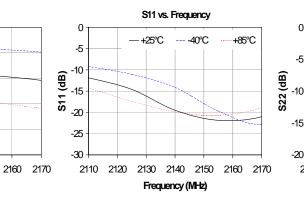
+25℃

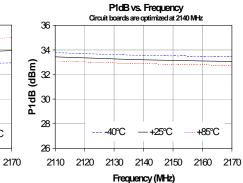
2130 2140 2150

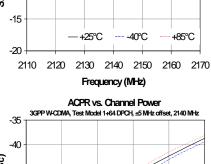
Frequency (MHz)

+85°C

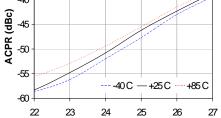
2160



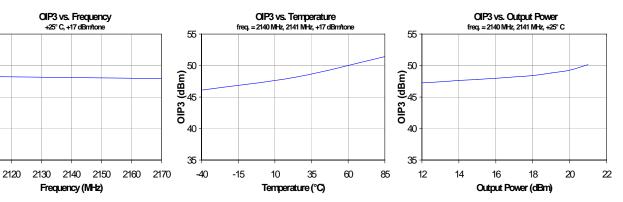




S22 vs. Frequency



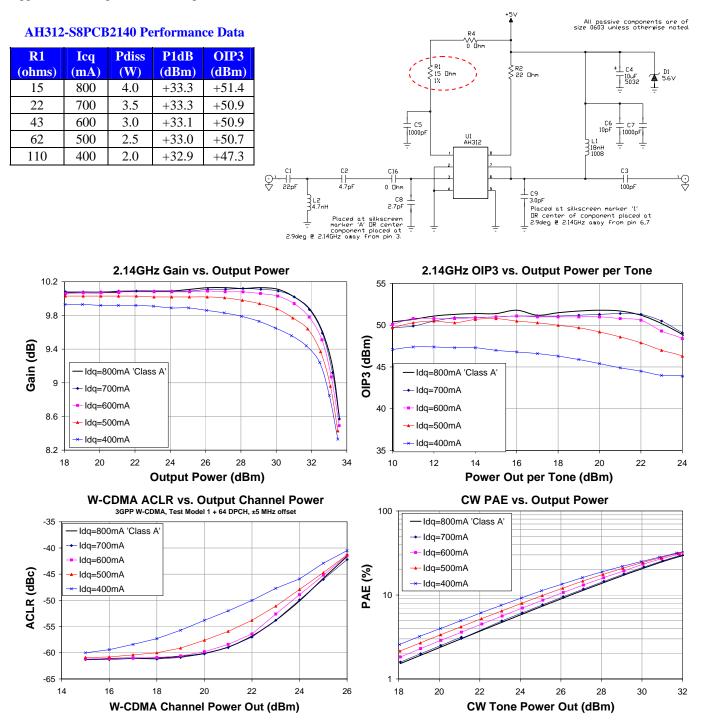






Application Note: Reduced Bias Configurations

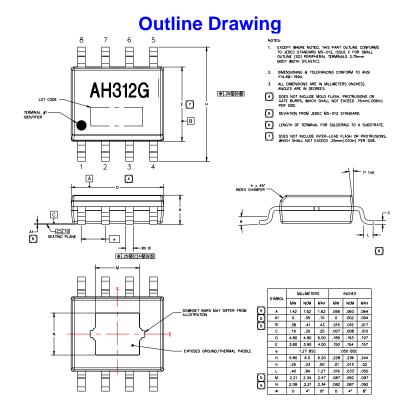
The AH312 can be configured to be operated with lower bias current by varying the bias-adjust resistor - R1. The recommended circuit configurations shown previously in this datasheet have the device operating in Class A operation. Lowering the current has little effect on the gain, OIP3, and P1dB performance of the device, but will slightly lower the ACLR/ACPR performance of the device as shown below. An example of the measured data below represents the AH312 measured and configured for 2.14 GHz applications. It is expected that variation of the bias current for other frequency applications will produce similar performance results.



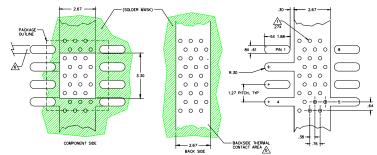


AH312-S8G (Lead-Free Package) Mechanical Information

This package is lead-free/green/RoHS-compliant. The plating material on the leads is NiPdAu. It is compatible with both lead-free (maximum 260 °C reflow temperature) and lead (maximum 245 °C reflow temperature) soldering processes.



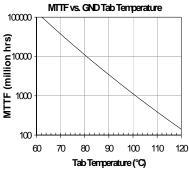
Mounting Configuration / Land Pattern



Thermal Specifications

| Parameter | Rating |
|---|---------------|
| Operating Case Temperature ⁽¹⁾ | -40 to +85 °C |
| Thermal Resistance (2), Rth | 17.5 °C / W |
| Junction Temperature ⁽³⁾ , Tjc | 155 °C |
| Notes: | |

- The amplifier can be operated at 105 °C case temperature for up to 1000 hours over its lifetime without degradation in performance and will not degrade device operation at the recommended maximum 85 °C case temperature for the rest of its lifetime.
- 2. The thermal resistance is referenced from the junction-to-case at a case temperature of 85 °C. Tjc is a function of the voltage at pins 6 and 7 and the current applied to pins 6, 7, and 8 and can be calculated by: Tjc = Tcase + Rth * Vcc * 1cc
- This corresponds to the typical biasing condition of +5V, 800 mA at an 85 °C case temperature. A minimum MTTF of 1 million hours is achieved for junction temperatures below 247 °C.



Product Marking

The component will be marked with an "AH312G" designator with an alphanumeric lot code on the top surface of the package. The obsoleted tin-lead version will have been marked with an "AH312-S8" or "ECP200G" designator.

Tape and reel specifications for this part are located on the website in the "Application Notes" section.

ESD / MSL Information

ESD Rating: Class 1B

| ESD Rating: | Class IB |
|-------------|------------------------------|
| Value: | Passes between 500 and 1000V |
| Test: | Human Body Model (HBM) |
| Standard: | JEDEC Standard JESD22-A114 |
| | |

MSL Rating: Level 2 at +260 °C convection reflow Standard: JEDEC Standard J-STD-020

Mounting Config. Notes

- A heatsink underneath the area of the PCB for the mounted device is strictly required for proper thermal operation. Damage to the device can occur without the use of one.
- Ground / thermal vias are critical for the proper performance of this device. Vias should use a .35mm (#80 / .0135") diameter drill and have a final plated thru diameter of .25 mm (.010").
- Add as much copper as possible to inner and outer layers near the part to ensure optimal thermal performance.
- Mounting screws can be added near the part to fasten the board to a heatsink. Ensure that the ground / thermal via region contacts the heatsink.
- Do not put solder mask on the backside of the PC board in the region where the board contacts the heatsink.
- 6. RF trace width depends upon the PC board material and construction.
- 7. Use 1 oz. Copper minimum.
- 8. All dimensions are in millimeters (inches). Angles are in degrees.